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WITH ENABLE

- Single-Chip RS-232 Interface for IBM™ **PC-Compatible Serial Port**
- Designed to Transmit and Receive 4-µs Pulses (Equivalent to 256 kbit/s)
- Standby Power Is Less Than 750 µW Maximum
- Wide Supply-Voltage Range . . . 4.75 V to 15 V
- **Driver Output Slew Rates Are Internally** Controlled to 30 V/us Maximum
- **RS-232 Bus-Pin ESD Protection Exceeds:** - 15 kV, Human-Body Model
- Receiver Input Hysteresis ... 1000 mV Typical
- Three Drivers and Five Receivers Meet or Exceed the Requirements of TIA/EIA-232-F and **ITU v.28 Standards**
- **Complements the SN75LP196**
- One Receiver Remains Active During WAKE-UP Mode (100 µA Maximum)
- **Matches Flow-Through Pinout of** Industry-Standard SN75185, SN75C185, and SN75LP185, With Additional Control Pins
- Package Options Include Plastic Shrink Small-Outline (DB), Small-Outline (DW), and Thin Shrink Small-Outline (PW) Packages, and Standard Plastic (NT) DIPs

description

The SN75LPE185 is a low-power bipolar device containing three drivers and five receivers, with 15-kV ESD protection on the bus pins, with respect to each other. Bus pins are defined as those pins that tie directly to the serial-port connector, including GND. The pinout matches the flow-through design of the industry-standard SN75185, SN75C185, and SN75LP185, with the addition of four pins for control signals. The flow-through pinout of the device allows easy interconnection of the universal asynchronous receiver/transmitter (UART) and serial-port connector of the IBM™ PC compatibles. The SN75LPE185 provides a rugged, low-cost solution for this function, with the combination of bipolar processing and 15-kV ESD protection.

The SN75LPE185 has an internal slew-rate control to provide a maximum rate of change in the output signal of 30 V/ μ s. The driver output swing is clamped at \pm 6 V to enable the higher data rates associated with this device and to reduce EMI emissions. Although the driver outputs are clamped, the outputs can handle voltages up to ±15 V without damage.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



DB, DW, NT, OR PW PACKAGE (TOP VIEW)									
, 									
V _{DD} [1	U	24	b	V _{CC}				
RA1 [2		23		RY1				
RA2 [3		22	þ	RY2				
RA3 [4		21		RY3				
DY1 [5		20	b	DA1				
DY2 [6		19	b	DA2				
RA4 [7		18	b	RY4				
DY3 [8		17	þ	DA3				
RA5 [9		16		RY5				
V _{SS} [10		15		GND				
EN [11		14		NC				
MODE [12		13	þ	NC				

NC - No internal connection

description (continued)

The device has flexible control options for power management when the serial port is inactive. A common disable for all of the drivers and receivers is provided with the active-low enable (\overline{EN}) input. The mode-control (MODE) input selects between the STANDBY and WAKE-UP modes. With a low-level input on MODE and a high-level input on \overline{EN} , one receiver remains active, while the remaining drivers and receivers are disabled to implement the WAKE-UP mode. With a high-level input on both MODE and \overline{EN} , all drivers and receivers are disabled to implement the STANDBY mode. The outputs of the drivers are in the high-impedance state when the device is powered off. To ensure the outputs of the receivers are in a known output level (as listed in the *Application Information* section of this data sheet) when the device is powered off, in STANDBY mode, or in WAKE-UP mode, external pullup/pulldown circuitry must be provided. All the logic inputs accept 3.3-V or 5-V input signals.

The SN75LPE185 complies with the requirements of TIA/EIA-232-F and ITU v.28 standards. These standards are for data interchange between a host computer and peripheral at signaling rates up to 20 kbit/s. The switching speeds of the SN75LPE185 support rates up to 256 kbit/s.

The SN75LPE185 is characterized for operation from 0°C to 70°C.

ſ		PACKAGED DEVICES							
	T _A	PLASTIC SHRINK SMALL OUTLINE (DB)	PLASTIC SMALL OUTLINE (DW)	PLASTIC THIN SHRINK SMALL OUTLINE (PW)	PLASTIC DIP (NT)				
ľ	0°C to 70°C	SN75LPE185DBR	SN75LPE185DW	SN75LPE185PWR	SN75LPE185NT				

AVAILABLE OPTIONS

The DB and PW packages are only available taped and reeled. The DW package is also available taped and reeled. Add the suffix R to device type (e.g., SN75LPE185DWR).

Function Tables

	DRIVERS						
INPUT DA	ENABLE EN	OUTPUT DY					
Х	Н	Z					
н	L	L					
L	L	н					
Open	L	L					
н	Open	L					
L	Open	н					

H = high level, L = low level,

X = irrelevant, Z = high impedance (off)



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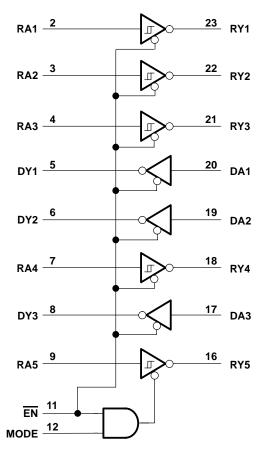
RECEIVERS

Function Tables (Continued)

INPUT	S	INPUTS		OUTPU	TS
RA1–RA4	RA5	EN	MODE	RY1–RY4	RY5
н	Н	L	Х	L	L
L	L	L	Х	н	н
X	н	н	L	Z	L
X	L	н	L	Z	Н
X	Х	н	н	Z	Z
Open	Open	L	Х	н	Н
н	н	L	Open	L	L
L	L	L	Open	н	Н
Х	н	н	Open	Z	L
Х	L	н	Open	Z	Н
н	Н	Open	Х	L	L
L	L	Open	Х	н	Н

H = high level, L = low level, X = irrelevant, Z = high impedance (off)

functional logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

	1)
V _{DD} (see Note	1) –0.5 V to 15 V
	e 1) 0.5 V to –15 V
Receiver input voltage range, V _I (RA)	
	E)
Receiver output voltage range, VO (RY)	
Driver output voltage range, V _O (DY)	
	dy model (see Note 2) Class 3: 15 kV
Machine m	odel (see Note 2) Class 3: 500 V
Electrostatic discharge, all pins: Human-boo	dy model (see Note 2) Class 3: 5 kV
Machine m	odel (see Note 2) Class 3: 200 V
Package thermal impedance, θ_{JA} (see Note 3	3): DB package 63°C/W
(see Note 3	3): DW package 46°C/W
(see Note 4): NT package
(see Note 3	3): PW package 88°C/W
Lead temperature 1,6 mm (1/16 inch) from ca	se for 10 seconds

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to network ground terminal unless otherwise noted.

2. Per MIL-STD-883 Method 3015.7

3. The package thermal impedance is calculated in accordance with JESD 51-7.

4. The package thermal impedance is calculated in accordance with JESD 51-3.

recommended operating conditions

			MIN	NOM	MAX	UNIT
VCC	Supply voltage (see Note 5)		4.75	5	5.25	V
V _{DD}	Supply voltage		9	12	15	V
VSS	Supply voltage		-9	-12	-15	V
VIH	High-level input voltage	DA, <mark>EN</mark> , MODE	2			V
VIL	Low-level input voltage	DA, <mark>EN</mark> , MODE			0.8	V
VI	Receiver input voltage range	RA	-25		25	V
IOH	High-level output current	RY			-1	mA
IOL	Low-level output current	RY			2	mA
Т _А	Operating free-air temperature		0		70	°C

NOTE 5: V_{CC} cannot be greater than V_{DD}.



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supply currents over the recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
		No load,	$V_{DD} = 9 V$, $V_{SS} = -9 V$, \overline{EN} at GND, See Note 6			1000		
ICC	Supply current for VCC	All inputs at	V_{DD} = 12 V, V_{SS} = -12 V, \overline{EN} at GND			1000	μA	
		minimum V _{OH} or maximum V _{OI}	EN, MODE at V _{CC}			650		
			EN at V _{CC} , MODE at GND			700		
		No load,	$V_{DD} = 9 V$, $V_{SS} = -9 V$, \overline{EN} at GND, See Note 6			800		
IDD	Supply current for VDD	All inputs at minimum V _{OH} or maximum V _{OI}		V_{DD} = 12 V, V_{SS} = -12 V, \overline{EN} at GND			800	μA
				EN, MODE at V _{CC}			20	
			EN at V _{CC} , MODE at GND			20		
		No load,	$V_{DD} = 9 V$, $V_{SS} = -9 V$, \overline{EN} at GND, See Note 6			-625		
ISS	Supply current for V _{SS} All inputs at $V_{DD} = 12 V$, $V_{SS} = -12 V$, \overline{EN} at	V_{DD} = 12 V, V_{SS} = -12 V, \overline{EN} at GND			-625	μA		
		minimum VOH or maximum VOL	EN, MODE at V _{CC}			-50		
			EN at V _{CC} , MODE at GND			-50		

NOTE 6: Minimum RS-232 driver output voltages are not attained with ±5-V supplies.

driver electrical characteristics over the recommended operating conditions (unless otherwise noted)

PARAMETER TEST CONDITIONS		ST CONDITIONS	MIN	TYP	MAX	UNIT	
Veri	High-level	VI = 0.8 V, RL = 3 kΩ,	$V_{DD} = 9 V$, $V_{SS} = -9 V$, \overline{EN} at GND, See Note 6	5	5.8	6.6	V
VOH	output voltage	See Figure 1	V_{DD} = 12 V, V _{SS} = -12 V, EN at GND, See Note 7	5	5.8	6.6	v
Vei	Low-level	V _I = 2 V, R _L = 3 K,	$V_{DD} = 9 V$, $V_{SS} = -9 V$, \overline{EN} at GND, See Note 6	-5	-5.8	-6.9	V
VOL	output voltage	See Figure 1	$\frac{V_{DD}}{EN}$ = 12 V, V _{SS} = -12 V, EN at GND, See Note 7	-5	-5.8	-6.9	v
IIH	High-level input current	V _I at V _{CC}				1	μΑ
۱ _{IL}	Low-level input current	V _I at GND				-1	μΑ
IOZ	High-impedance output current	$V_{CC} = 5 V, V_{DD} = 12 V, V_{S}$	$SS = -12 \text{ V}, -5 \text{ V} \le \text{V}_{O} \le 5 \text{ V}$			±100	μΑ
IOS(H)	Short-circuit high-level output current	$V_{O} = GND \text{ or } V_{SS},$	See Figure 2 and Note 8		-30	-55	mA
IOS(L)	Short-circuit low-level output current	$V_{O} = GND \text{ or } V_{SS},$	See Figure 2 and Note 8		30	55	mA
r _O	Output resistance	$V_{DD} = V_{SS} = V_{CC} = 0,$	$V_{O} = 2 V$	300			Ω

NOTES: 6. Minimum RS-232 driver output voltages are not attained with \pm 5-V supplies.

7. Maximum output swing is limited to ± 5.5 V to enable the higher data rates associated with this device and to reduce EMI emissions.

8. Not more than one output should be shorted at one time.



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driver switching characteristics over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TES	T CONDITIONS	MIN	TYP	MAX	UNIT
^t PHL	Propagation delay time, high- to low-level output	$R_L = 3 k\Omega$ to 7 kΩ,	C _L = 15 pF, See Figure 1	300	800	1600	ns
^t PLH	Propagation delay time, low- to high-level output	$R_L = 3 k\Omega$ to 7 k Ω ,	C _L = 15 pF, See Figure 1	300	800	1600	ns
^t PZL	Driver output-enable time to low-level output	$R_L = 3 k\Omega$ to 7 kΩ, $C_L = 15 pF$	STANDBY or WAKE-UP modes, See Figures 1 and 6 and Note 7		50	100	μs
^t PZH	Driver output-enable time to high-level output	$R_L = 3 k\Omega$ to 7 kΩ, $C_L = 15 pF$	STANDBY or WAKE-UP modes, See Figures 1 and 6 and Note 7		50	100	μs
^t PLZ	Driver output-disable time from low-level output	$R_L = 3 k\Omega$ to 7 kΩ, $C_L = 15 pF$	STANDBY or WAKE-UP modes, See Figures 1 and 6 and Note 7		50	100	μs
^t PHZ	Driver output-disable time from high-level output	$R_L = 3 k\Omega$ to 7 kΩ, $C_L = 15 pF$	STANDBY or WAKE-UP modes, See Figures 1 and 6 and Note 7		50	100	μs
			Using 10%-to-90% transition region, Driver speed = 250 kbit/s, $C_L = 15 \text{ pF}$	375		2240	
t	Transition time,	$V_{CC} = 5 V,$ $V_{DD} = 12 V,$	Using \pm 3-V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	200		1500	ns
ttlh	low- to high-level output	$\label{eq:VSS} \begin{array}{l} V_{SS} = -12 \ V, \\ R_L = 3 \ k\Omega \ \text{to} \ 7 \ k\Omega, \\ \text{See Figure 1 and Note 7} \end{array}$	Using \pm 2-V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	133		1000	115
			Using \pm 3-V transition region, Driver speed = 125 kbit/s, C _L = 2500 pF			2750	
			Using 10%-to-90% transition region, Driver speed = 250 kbit/s, C _L = 15 pF	375		2240	
4	Transition time,	$V_{CC} = 5 V,$ $V_{DD} = 12 V,$	Using \pm 3-V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	200		1500	
t⊤HL	high- to low-level output	$V_{SS} = -12 \text{ V},$ R _L = 3 k Ω to 7 k Ω , See Figure 1 and Note 7	Using ± 2 -V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	133		1000	ns
			Using \pm 3-V transition region, Driver speed = 125 kbit/s, C _L = 2500 pF			2750	
SR	Output slew rate	$V_{CC} = 5 V,$ $V_{DD} = 12 V,$ $V_{SS} = -12 V,$ $R_L = 3 k\Omega \text{ to } 7 k\Omega,$ $C_L = 15 \text{ pF},$ See Note 7	Using ±3-V transition region, Driver speed = 0 to 250 kbit/s	4	20	30	V/µs

NOTE 7: Maximum output swing is limited to ±5.5 V to enable the higher data rates associated with this device and to reduce EMI emissions.



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receiver electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST	CONDITIONS	MIN	TYP	MAX	UNIT
VIT+	Positive-going input threshold voltage	See Figure 3		1.6	2	2.55	V
V _{IT} _	Negative-going input threshold voltage	See Figure 3		0.6	1	1.45	V
V _{HYS}	Input hysteresis, V _{IT+} – V _{IT} _	See Figure 3		600	1100		mV
VOH	High-level output voltage	I _{OH} = -1 mA		2.5	3.9		V
VOL	Low-level output voltage	I _{OL} = 2 mA			0.33	0.5	V
1	High-level input current	V _I = 3 V		0.43	0.6	1	mA
lιΗ	High-level input current	V _I = 25 V		3.6	5.1	8.3	ma
1	Low-level input current	$V_{I} = -3 V$		-0.43	-0.6	-1	mA
ΊL	Low-level input current	V _I = -25 V		-3.6	-5.1	-8.3	ma
IOS(H)	Short-circuit high-level output current	$V_{O} = 0,$	See Figure 5 and Note 8			-20	mA
IOS(L)	Short-circuit low-level output current	$V_{O} = V_{CC},$	See Figure 5 and Note 8			20	mA
Ioz	High-impedance output current	V _{CC} = 0 or 5 V,	$0.3 \text{ V} \leq \text{V}_O \leq \text{V}_{CC}$			±100	μA
R _{IN}	Input resistance	$V_I = \pm 3 V \text{ to } \pm 25 V$		3	5	7	kΩ

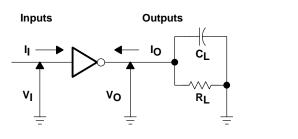
NOTE 8: Not more than one output should be shorted at one time.

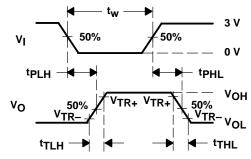
receiver switching characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
^t PHL	Propagation delay time, high- to low-level output			400	900	ns
^t PLH	Propagation delay time, low- to high-level output			400	900	ns
^t TLH	Transition time low- to high-level output			200	500	ns
^t THL	Transition time high- to low-level output			200	400	ns
^t SK(P)	Pulse skew tpLH - tpHL	STANDBY mode		200	425	ns
^t PZL	Receiver output-enable time to low-level output	C _L = 50 pF,		50	100	μs
^t PZH	Receiver output-enable time to high-level output	See Figures 4 and 7		50	100	μs
^t PLZ	Receiver output-disable time from low-level output			50	100	μs
^t PHZ	Receiver output-disable time from high-level output			50	100	μs
^t PHL	Propagation delay time, high- to low-level output (WAKE-UP mode)			500	1500	ns
^t PLH	Propagation delay time, low- to high-level output (WAKE-UP mode)			500	1500	ns



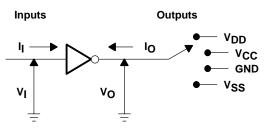
PARAMETER MEASUREMENT INFORMATION



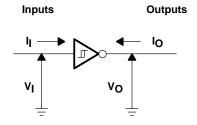


NOTES: A. The pulse generator has the following characteristics: For $C_L < 1000 \text{ pF}$: $t_W = 4 \text{ }\mu\text{s}$, PRR = 250 kbit/s, $Z_O = 50 \Omega$, $t_f = t_f < 50 \text{ }n\text{s}$. For $C_L = 2500 \text{ pF}$: $t_W = 8 \text{ }\mu\text{s}$, PRR = 125 kbit/s, $Z_O = 50 \Omega$, $t_f = t_f < 50 \text{ }n\text{s}$. B. CL includes probe and jig capacitance.

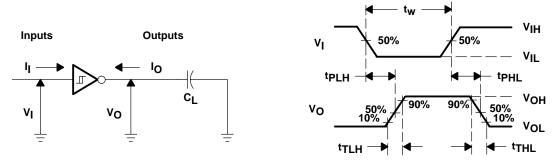












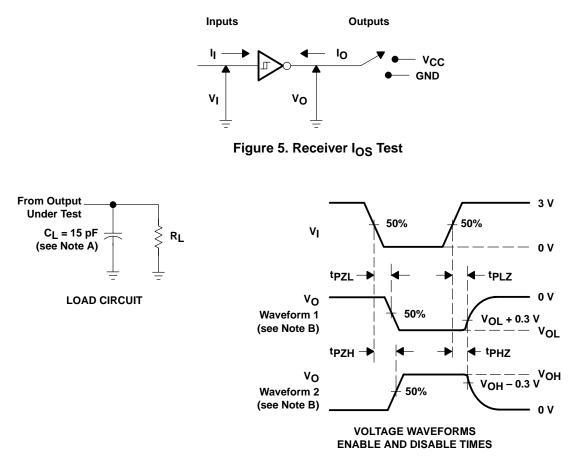
NOTES: A. The pulse generator has the following characteristics: $t_W = 4 \mu s$, PRR = 250 kbit/s, $Z_O = 50 \Omega$, $t_r = t_f < 50 ns$. B. CL includes probe and jig capacitance.

Figure 4. Receiver Parameter Test Circuit and Waveform



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PARAMETER MEASUREMENT INFORMATION

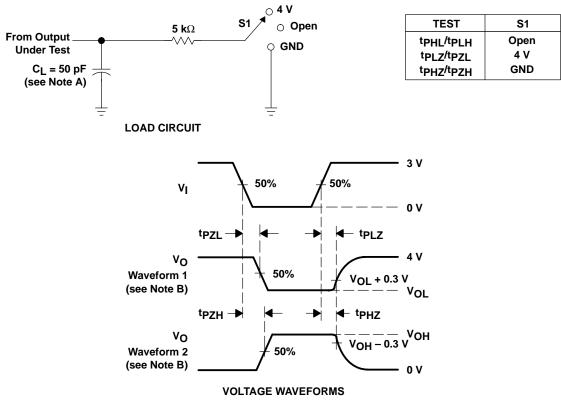


- NOTES: A. CL includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR = 250 kbit/s, $Z_{O} = 50 \Omega$, $t_{r} = t_{f} < 50$ ns.
 - D. The outputs are measured one at a time with one transition per measurement.

Figure 6. Driver 3-State Parameter Load Circuit and Voltage Waveforms



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PARAMETER MEASUREMENT INFORMATION

ENABLE AND DISABLE TIMES

- NOTES: A. CL includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR = 250 kbit/s, $Z_O = 50 \Omega$, $t_f = t_f < 50 ns$.
 - D. The outputs are measured one at a time with one transition per measurement.

Figure 7. Receiver 3-State Parameter Load Circuit and Voltage Waveforms



APPLICATION INFORMATION

receiver output states

RECEIVER KNOWN OUTPUT STATES DURING POWER-DOWN, STANDBY, OR WAKE-UP MODES							
RECEIVER NUMBER	RECEIVER NUMBER SIGNAL NAME RECEIVER OUTPUT						
RY1	DCD	High					
RY2	DSR	High					
RY3	RX	Low					
RY4	CTS	High					
RY5	RI	High					

fault protection during power down

Diodes placed in series with the V_{DD} and V_{SS} leads protect the SN75LPE185 in the fault condition, in which the device outputs are shorted to \pm 15 V and the power supplies are at low voltage and provide low-impedance paths to ground.

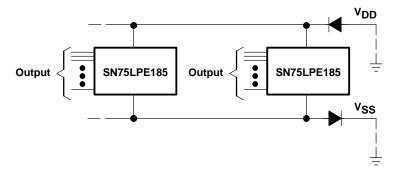


Figure 8. Power-Supply Protection to Meet Power-Off Fault Conditions of TIA/EIA-232-F



APPLICATION INFORMATION

WAKE-UP mode

While in the WAKE-UP mode, all the drivers and receivers of the SN75LPE185 device are in the high-impedance state, except for receiver 5, which can be used as a ring indicator function. In this mode, the current drawn from the power supplies is low, to conserve power.

In today's PCs, board designers are becoming more concerned about power consumption. The flexibility of the SN75LPE185 during WAKE-UP mode allows the designer to operate the device at auxiliary power-supply voltages below specified levels. The SN75LPE185 functions properly during WAKE-UP mode, using the following power-supply conditions:

- (a) V_{CC} = 4.75 V, V_{DD} = 9 V, and V_{SS} = -9 V (data-sheet specifications)
- (b) $V_{CC} = 5 V$, $V_{DD} = 5 V$, and $V_{SS} = -5 V$
- (c) $V_{CC} = 5 V$, $V_{DD} = open$, and $V_{SS} = open$
- (d) $V_{CC} = 5 V$, $V_{DD} = 5 V$, and V_{SS} is shorted to the most negative supply.

Condition (a) describes the minimum supply voltages necessary for the device to comply fully to specifications.

Conditions (b) and (d) describe the condition where a - 5-V supply is not available during auxiliary power. In this case, V_{SS} must be shorted to the most negative supply (i.e., GND or a voltage source close to, but below GND).

Condition (c) states V_{DD} and V_{SS} power supplies can be shut off.

In all cases, GND is understood to be 0 V, and the power-supply voltages should never exceed the absolute maximum ratings.





PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
SN75LPE185DWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
SN75LPE185DWRE4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
SN75LPE185DWRG4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
SN75LPE185NT	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	Purchase Samples
SN75LPE185NTE4	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	Purchase Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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PACKAGE MATERIALS INFORMATION

www.ti.com

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TEXAS INSTRUMENTS





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

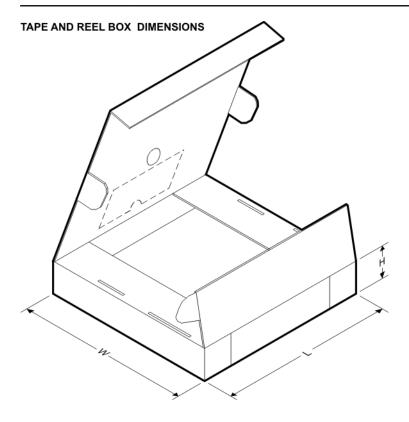
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN75LPE185DWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

14-Jul-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN75LPE185DWR	SOIC	DW	24	2000	367.0	367.0	45.0

NT (R-PDIP-T**) 24 pins shown

PLASTIC DUAL-IN-LINE PACKAGE



All integrations are in minimeters. Dimensioning and toil
B. This drawing is subject to change without notice.

The 28 pin end lead shoulder width is a vendor option, either half or full width.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



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